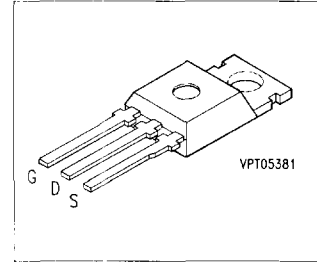


SIPMOS® Power Transistors

- N channel
- Enhancement mode
- Avalanche-rated

BUZ 76 BUZ 76 A



Type	V_{DS}	I_D	T_C	$R_{DS(on)}$	Package ¹⁾	Ordering Code
BUZ 76	400 V	3.0 A	37 °C	1.8 Ω	TO-220 AB	C67078-S1315-A2
BUZ 76 A	400 V	2.7 A	23 °C	2.5 Ω	TO-220 AB	C67078-S1315-A3

Maximum Ratings

Parameter	Symbol	BUZ		Unit
		76	76 A	
Continuous drain current	I_D	3.0	2.7	A
Pulsed drain current, $T_C = 25$ °C	$I_{D\text{ puls}}$	12	11	
Avalanche current, limited by $T_{j\text{ max}}$	I_{AR}	3		
Avalanche energy, periodic limited by $T_{j\text{ (max)}}$	E_{AR}	5		mJ
Avalanche energy, single pulse $I_D = 3$ A, $V_{DD} = 50$ V, $R_{GS} = 25$ Ω $L = 35$ mH, $T_j = 25$ °C	E_{AS}	180		
Gate-source voltage	V_{GS}	± 20		V
Power dissipation, $T_C = 25$ °C	P_{tot}	40		W
Operating and storage temperature range	T_j, T_{stg}	-55 ... +150		°C
Thermal resistance, chip-case	$R_{th\text{ JC}}$	≤ 3.1		K/W
DIN humidity category, DIN 40 040	-	E		-
IEC climatic category, DIN IEC 68-1	-	55/150/56		

1) See chapter Package Outlines.

Electrical Characteristics

at $T_j = 25\text{ °C}$, unless otherwise specified.

Parameter	Symbol	Values			Unit
		min.	typ.	max.	

Static characteristics

Drain-source breakdown voltage $V_{GS} = 0\text{ V}$, $I_D = 0.25\text{ mA}$	$V_{(BR)DSS}$	400	–	–	V
Gate threshold voltage $V_{GS} = V_{DS}$, $I_D = 1\text{ mA}$	$V_{GS(th)}$	2.1	3.0	4.0	
Zero gate voltage drain current $V_{DS} = 400\text{ V}$, $V_{GS} = 0\text{ V}$ $T_j = 25\text{ °C}$ $T_j = 125\text{ °C}$	I_{DSS}	–	0.1 10	1.0 100	μA
Gate-source leakage current $V_{GS} = 20\text{ V}$, $V_{DS} = 0\text{ V}$	I_{GSS}	–	10	100	nA
Drain-source on-resistance $V_{GS} = 10\text{ V}$, $I_D = 2.0\text{ A}$ BUZ 76 BUZ 76 A	$R_{DS(on)}$	–	1.4 2.0	1.8 2.5	Ω

Dynamic characteristics

Forward transconductance $V_{DS} \geq 2 \times I_D \times R_{DS(on)max}$, $I_D = 2.0\text{ A}$	g_{fs}	2.1	3.0	–	S
Input capacitance $V_{GS} = 0\text{ V}$, $V_{DS} = 25\text{ V}$, $f = 1\text{ MHz}$	C_{iss}	–	430	650	pF
Output capacitance $V_{GS} = 0\text{ V}$, $V_{DS} = 25\text{ V}$, $f = 1\text{ MHz}$	C_{oss}	–	65	100	
Reverse transfer capacitance $V_{GS} = 0\text{ V}$, $V_{DS} = 25\text{ V}$, $f = 1\text{ MHz}$	C_{rss}	–	25	40	
Turn-on time t_{on} , ($t_{on} = t_{d(on)} + t_r$) $V_{DD} = 30\text{ V}$, $V_{GS} = 10\text{ V}$, $I_D = 2.5\text{ A}$, $R_{GS} = 50\text{ }\Omega$	$t_{d(on)}$	–	8	12	ns
	t_r	–	30	45	
Turn-off time t_{off} , ($t_{off} = t_{d(off)} + t_f$) $V_{DD} = 30\text{ V}$, $V_{GS} = 10\text{ V}$, $I_D = 2.5\text{ A}$, $R_{GS} = 50\text{ }\Omega$	$t_{d(off)}$	–	55	75	
	t_f	–	30	40	

Electrical Characteristics (cont'd)

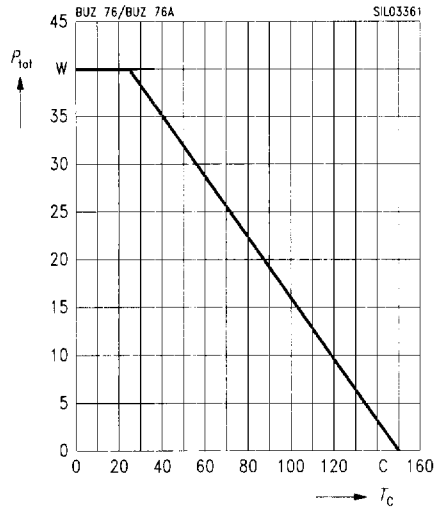
at $T_j = 25\text{ }^\circ\text{C}$, unless otherwise specified.

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
Reverse diode					
Continuous reverse drain current $T_C = 25\text{ }^\circ\text{C}$	I_S				A
BUZ 76		-	-	3.0	
BUZ 76 A		-	-	2.7	
Pulsed reverse drain current $T_C = 25\text{ }^\circ\text{C}$	I_{SM}				
BUZ 76		-	-	12	
BUZ 76 A		-	-	11	
Diode forward on-voltage $I_S = 6.0\text{ A}$, $V_{GS} = 0\text{ V}$	V_{SD}	-	1.0	1.4	V
Reverse recovery time $V_R = 100\text{ V}$, $I_F = I_S$, $di_F / dt = 100\text{ A}/\mu\text{s}$	t_{rr}	-	300	-	ns
Reverse recovery charge $V_R = 100\text{ V}$, $I_F = I_S$, $di_F / dt = 100\text{ A}/\mu\text{s}$	Q_{rr}	-	2.5	-	μC

Characteristics at $T_i = 25\text{ }^\circ\text{C}$, unless otherwise specified.

Total power dissipation

$$P_{\text{tot}} = f(T_C)$$

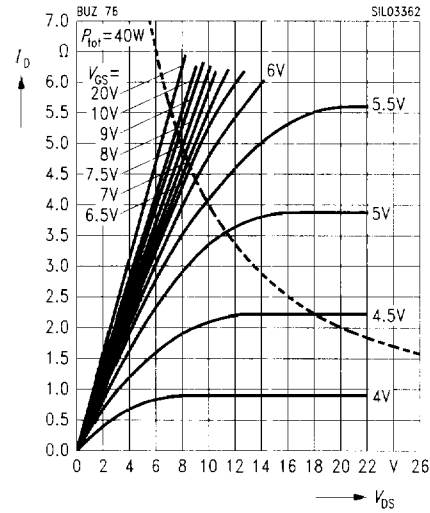


Typ. output characteristics

$$I_D = f(V_{DS})$$

parameter: $t_p = 80\text{ }\mu\text{s}$

BUZ 76

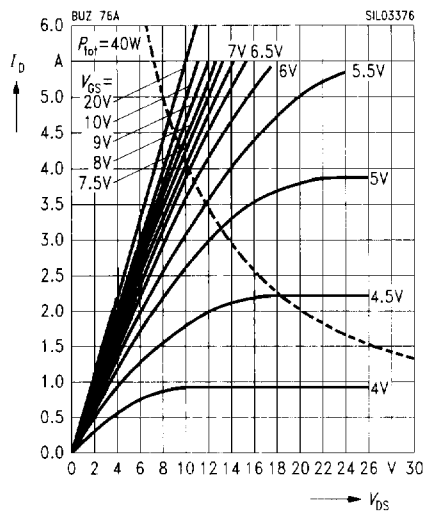


Typ. output characteristics

$$I_D = f(V_{DS})$$

parameter: $t_p = 80\text{ }\mu\text{s}$

BUZ 76 A

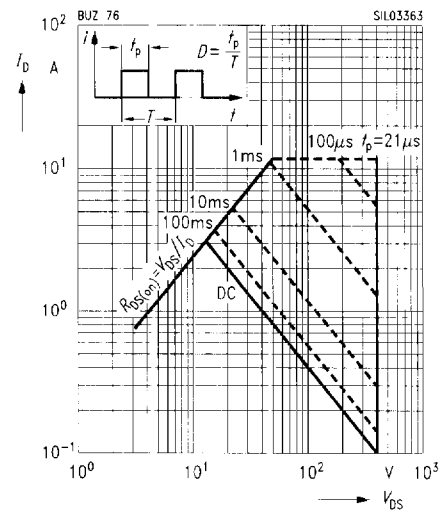


Safe operating area

$$I_D = f(V_{DS})$$

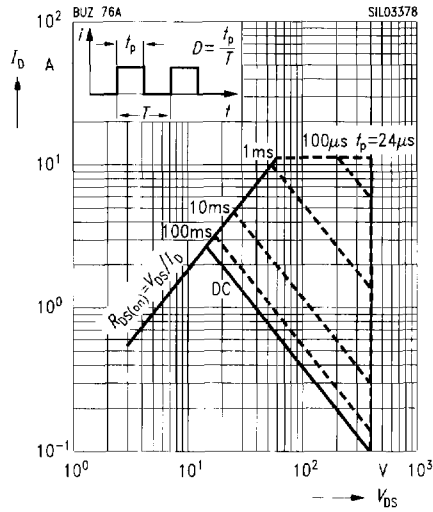
parameter: $D = 0.01, T_C = 25\text{ }^\circ\text{C}$

BUZ 76



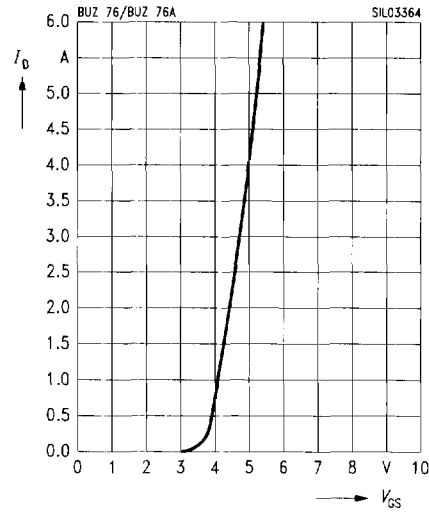
Safe operating area

$I_D = f(V_{DS})$ **BUZ 76 A**
parameter: $D = 0.01$, $T_C = 25^\circ\text{C}$



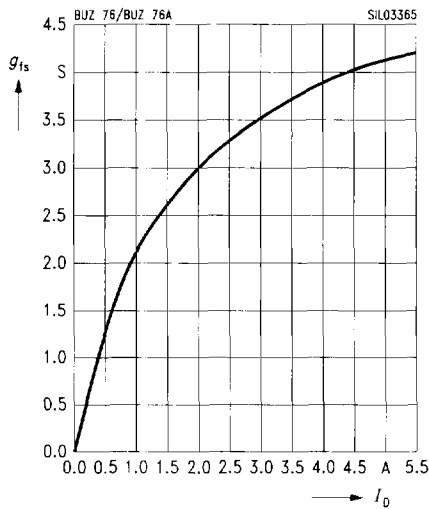
Typ. transfer characteristics

$I_D = f(V_{GS})$
parameter: $t_p = 80\ \mu\text{s}$, $V_{DS} = 25\ \text{V}$



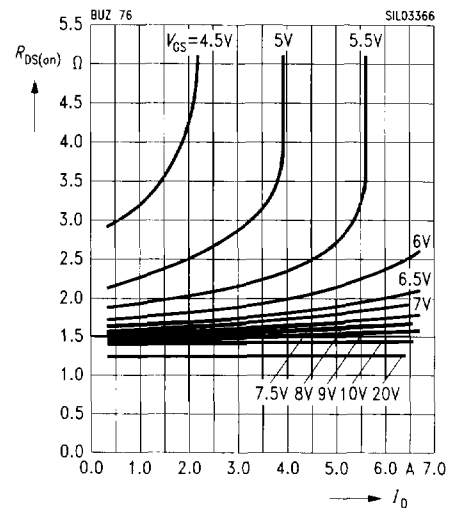
Typ. forward transconductance

$g_{fs} = f(I_D)$
parameter: $t_p = 80\ \mu\text{s}$



Typ. drain-source on-resistance

$R_{DS(on)} = f(I_D)$ **BUZ 76**
parameter: V_{GS}

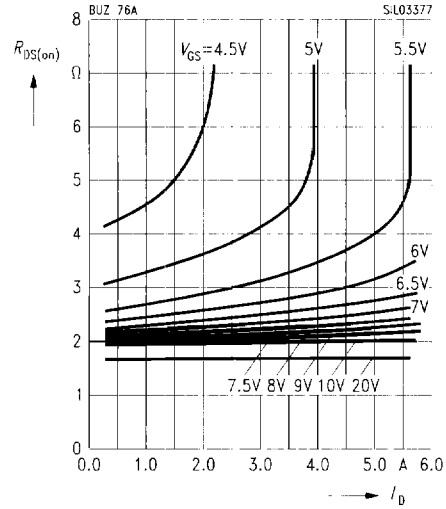


Typ. drain-source on-resistance

$R_{DS(on)} = f(I_D)$

parameter: V_{GS}

BUZ 76 A

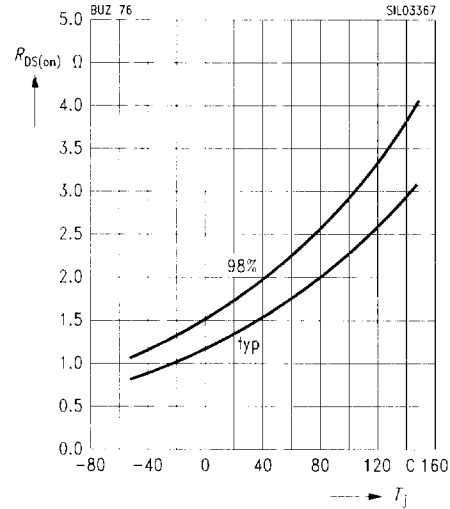


Drain-source on-resistance

$R_{DS(on)} = f(T_j)$

parameter: $I_D = 2$ A, $V_{GS} = 10$ V, (spread)

BUZ 76

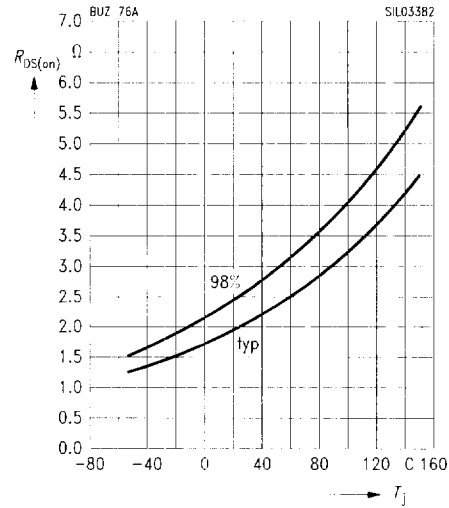


Drain-source on-resistance

$R_{DS(on)} = f(T_j)$

parameter: $I_D = 2$ A, $V_{GS} = 10$ V, (spread)

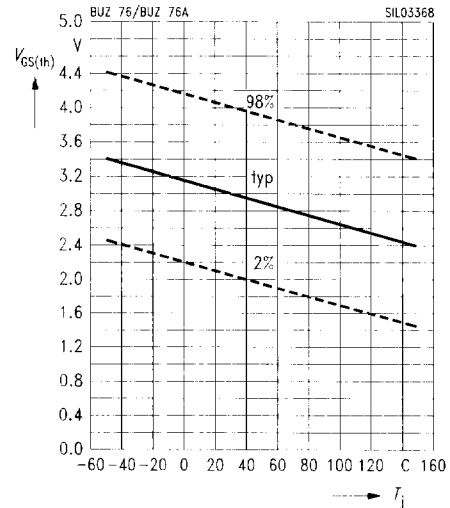
BUZ 76 A



Gate threshold voltage

$V_{GS(th)} = f(T_j)$

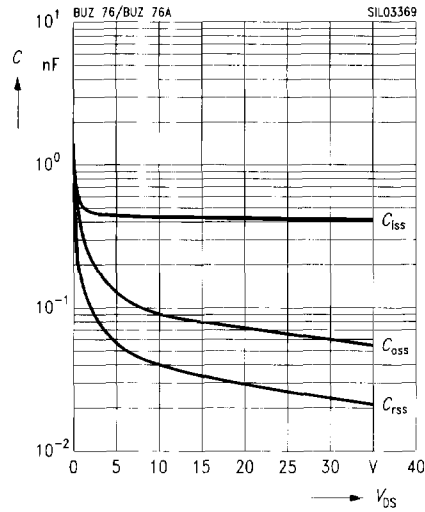
parameter: $V_{GS} = V_{DS}$, $I_D = 1$ mA, (spread)



Typ. capacitances

$$C = f(V_{DS})$$

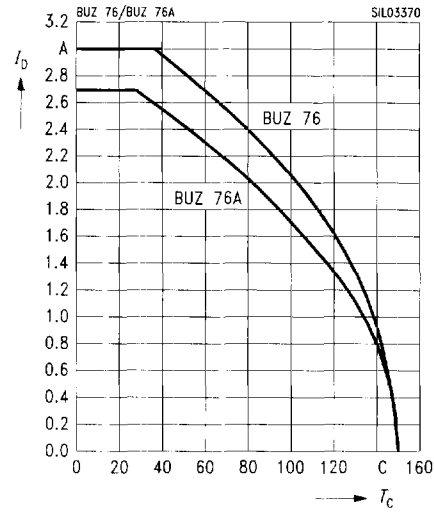
parameter: $V_{GS} = 0 \text{ V}$, $f = 1 \text{ MHz}$



Drain current

$$I_D = f(T_C)$$

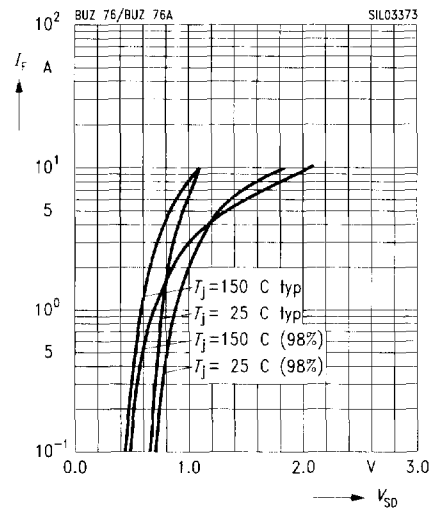
parameter: $V_{GS} \geq 10 \text{ V}$



Forward characteristics of reverse diode

$$I_F = f(V_{SD})$$

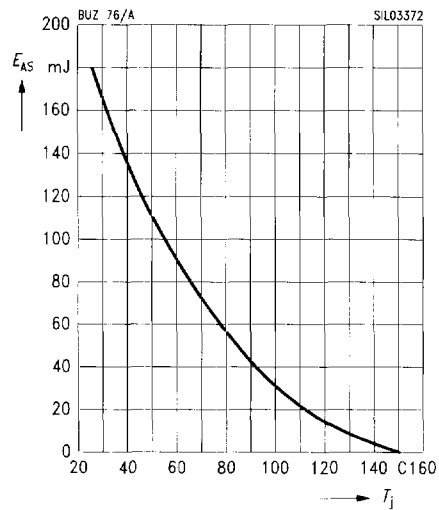
parameter: T_j , $t_p = 80 \mu\text{s}$



Avalanche energy $E_{AS} = f(T_j)$

parameter: $I_D = 3 \text{ A}$, $V_{DD} = 50 \text{ V}$

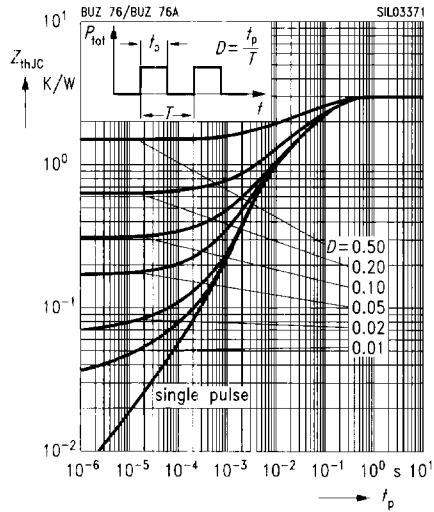
$R_{GS} = 25 \Omega$, $L = 35 \text{ mH}$



Transient thermal impedance

$$Z_{th,JC} = f(t_p)$$

parameter: $D = t_p / T$



Typ. gate charge

$$V_{GS} = f(Q_{Gate})$$

parameter: $I_{D,puls} = 6$ A

